## **Innovating Energy Technology**

# FML60N150S2FDHF

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**FUJI POWER MOSFET** 

## Super J MOS® S2 series

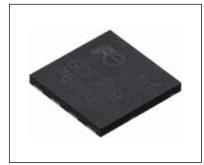
### N-Channel enhancement mode power MOSFET

#### Features

Pb-free lead terminal RoHS compliant Halogen-free molding compound MSL:1, Reflow available

#### Applications

For switching



DFN8x8 (Out view: see to 7/8 page)

Package and Internal circuit chart

#### ■ Absolute Maximum Ratings at T<sub>c</sub>=25°C (unless otherwise specified)

Parameter	Symbol	Characteristics	Unit	Remarks
Duein Course Voltone	<b>V</b> <sub>DS</sub>	600	V	
Drain-Source Voltage	V <sub>DSX</sub>	600	V	V <sub>GS</sub> = - 30 V
Ossatisas and Duning Ossans at		28.7	Α	Tc=25°C Note*1,2
Continuous Drain Current	I <sub>D</sub>	18.2	Α	Tc=100°C Note*1,2
Pulsed Drain Current	<b>I</b> DP	83.6	Α	Note *2
Gate-Source Voltage	<b>V</b> <sub>GS</sub>	±30	V	
Non-Repetitive Maximum Avalanche Current	<b>I</b> AS	3.5	А	Note *3
Non-Repetitive Maximum Avalanche Energy	Eas	517.5	mJ	Note *4
Maximum MOSFET dv/dt	d <i>v</i> ⊳s/d <i>t</i>	50	V/ns	<i>V</i> <sub>DS</sub> ≤ 600V
Continuous	,	28.7	Α	Tc=25°C Note*1,2
Diode Forward Current	<b>I</b> DR	18.2	Α	Tc=100°C Note*1,2
Pulsed Diode Forward Current	<b>I</b> DRP	83.6	Α	Note *2
Peak Diode Recovery dv/dt	dv/dt	30	V/ns	Note *5
Peak Diode Recovery -didr/dt	-di <sub>DR</sub> /dt	100	A/µs	Note *6
Maximum Daway Dissination	P <sub>tot</sub>	159	W	<i>T</i> c=25°C
Maximum Power Dissipation	<b>P</b> tot	2.78	W	<i>T</i> <sub>a</sub> =25°C
Operating Channel Temperature	<b>T</b> ch	150	°C	
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C	

Note \*1 : Maximum duty cycle D=0.55

Note \*1 : Maximum duty cycle D=0.50Note \*2 : Limited by maximum channel temperature. Note \*3 :  $T_{ch} \le 150$  °C, See Figure 1 and 2. Note \*4 : Starting  $T_{ch} = 25$  °C,  $I_{AS} = 2.1$  A, L = 215 mH,  $V_{DD} = 60$  V,  $R_{G} = 50$   $\Omega$ , See Figure 1 and 2. Eas limited by maximum channel temperature and avalanche current.

Note \*5 :  $I_{\rm NS}$  = 22.7 A ,  $-d_{\rm IDR}/dt \le 100$  A/µs, Vos peak  $\le 600$  V,  $T_{\rm ch} \le 150$  °C. Note \*6 :  $I_{\rm DR} \le 22.7$  A ,  $d_{\rm V}/dt \le 30$  V/ns, Vos peak  $\le 600$  V,  $T_{\rm ch} \le 150$  °C.

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# ■ Electrical Characteristics at *T*<sub>c</sub>=25°C (unless otherwise specified) • Static characteristics

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>es</sub> = 0 V I <sub>D</sub> = 250 μA		600	-	-	V
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ $I_D = 3.5 \text{ mA}$		3.0	4.0	5.0	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 600 V V <sub>GS</sub> = 0 V	T <sub>ch</sub> = 25 °C	-	-	25	μА
		V <sub>DS</sub> = 480 V V <sub>GS</sub> = 0 V	T <sub>ch</sub> = 125 °C	-	-	-	
Gate-Source Leakage Current	<b>I</b> GSS	V <sub>DS</sub> = 0 V V <sub>GS</sub> = ± 30 V		-	10	100	nA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>cs</sub> = 10 V I <sub>D</sub> = 5.7 A		-	0.134	0.150	Ω
Gate resistance	r <sub>g</sub>	f = 1 MHz, open drain		-	8.3	_	Ω

#### • Dynamic characteristics

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> = 25 V I <sub>D</sub> = 11.4 A	4	16	-	S
Input Capacitance	Ciss	V <sub>DS</sub> = 400 V	-	1190	-	
Output Capacitance	Coss	$V_{GS} = 0 \text{ V}$	-	42	-	
Reverse Transfer Capacitance	Crss	f = 250 kHz	-	5.8	-	
Effective output capacitance, energy related (Note *7)	C <sub>o(er)</sub>	V <sub>DS</sub> = 0400 V V <sub>GS</sub> = 0 V	-	103	-	pF
Effective output capacitance, time related (Note *8)	C <sub>o(tr)</sub>	V <sub>DS</sub> = 0400 V V <sub>GS</sub> = 0 V I <sub>D</sub> = constant	-	410	-	
Turn-On Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 400 V	-	28	-	
Turn-On Time	<b>t</b> r	$V_{\text{GS}} = 10 \text{ V}$ $V_{\text{D}} = 11.4 \text{ A}$	-	14	-	20
Turn-Off Time	t <sub>d(off)</sub>	$R_{\rm G} = 33 \Omega$	-	240	-	ns
	<b>t</b> f	See Figure 3 and 4	-	24	-	
Total Gate Charge	<b>Q</b> <sub>G</sub>	$V_{DD} = 400 \text{ V}$ $V_{GS} = 10 \text{ V}$ $I_D = 22.7 \text{ A}$ See Figure 5	-	59	-	
Gate-Source Charge	<b>Q</b> GS		-	20	-	nC
Gate-Drain Charge	<b>Q</b> <sub>GD</sub>		-	27	-	

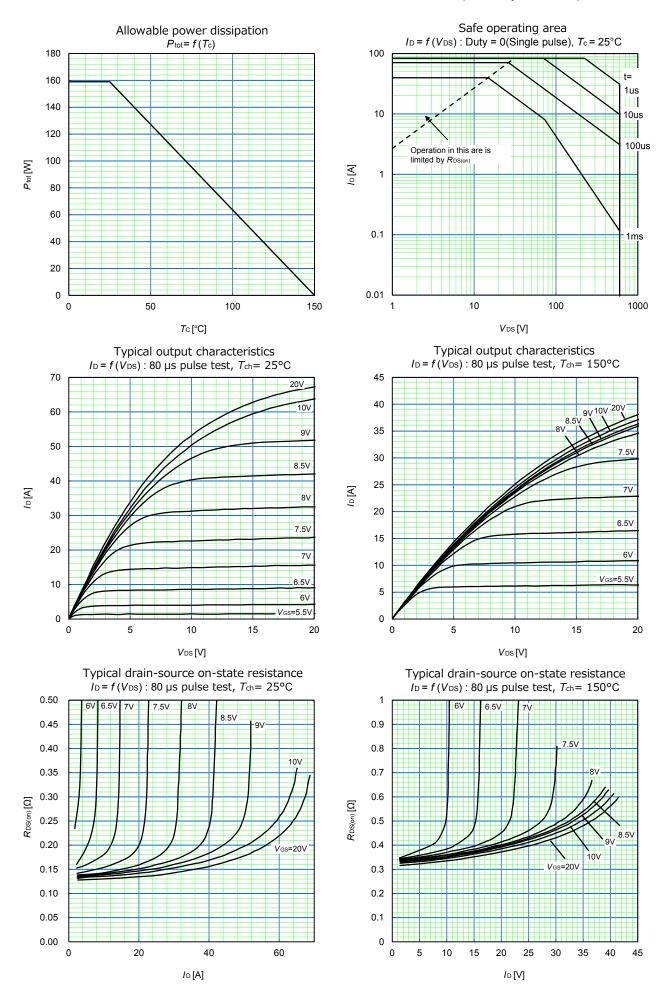
Note  $^*7$ :  $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{DS}$  is rising from 0 to 400 V. Note  $^*8$ :  $C_{\text{o(er)}}$  is a fixed capacitance that gives the same charging times as  $C_{\text{oss}}$  while  $V_{DS}$  is rising from 0 to 400 V.

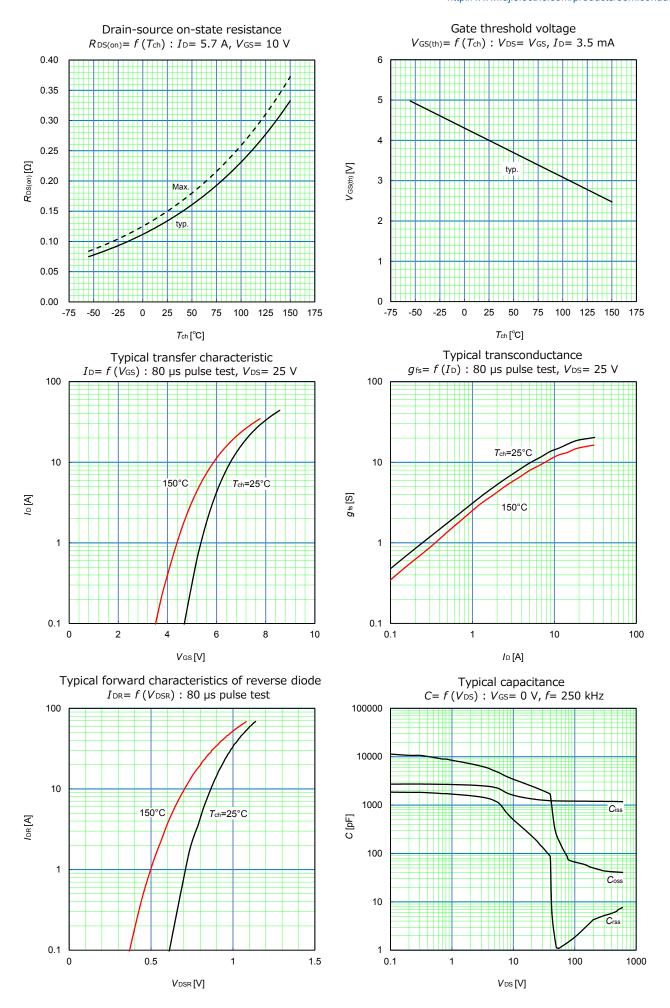
#### • Reverse diode characteristics

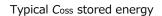
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Diode Forward On-Voltage	<b>V</b> <sub>DSR</sub>	I <sub>DR</sub> = 22.7 A, V <sub>GS</sub> = 0 V T <sub>ch</sub> = 25 °C	-	1.00	1.35	V
Reverse Recovery Time	<b>t</b> rr	$V_{DD} = 400 \text{ V}$ $I_{DR} = 22.7 \text{ A}$ $V_{GS} = 0 \text{ V}$ $-d_{DR}/dt = 100 \text{ A/}\mu\text{s}$ $T_{ch} = 25 \text{ °C}$ See Figure 6 and 7	-	160	-	ns
Reverse Recovery Charge	Qrr		-	1.2	-	μC
Peak Reverse Recovery Current	I <sub>rrm</sub>		-	14.5	-	Α

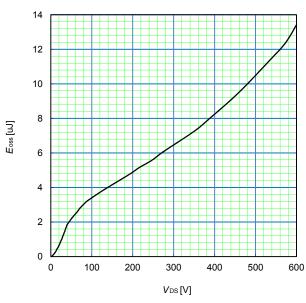
#### ■ Thermal Resistance

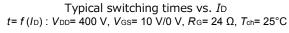
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Thermal Resistance, Channel – Ambient	R <sub>th(ch-a)</sub>	Device mounted on PCB (FR4) Size:40mm*40mm*1.5mm with 6cm² copper area (one layer, 70µm thickness) for drain connection and cooling.	-	-	45	°C/W
Thermal Resistance, Channel – Case	R <sub>th(ch-c)</sub>		-	-	0.786	°C/W

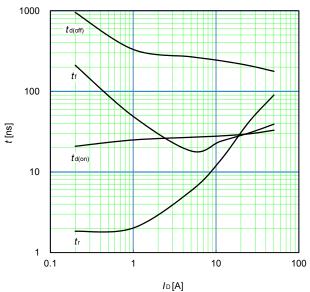




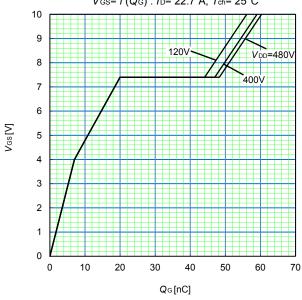




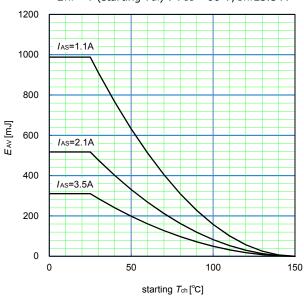




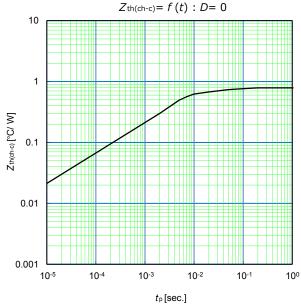
Typical gate charge V<sub>GS</sub>= f(Q<sub>G</sub>): I<sub>D</sub>= 22.7 A, T<sub>Ch</sub>= 25°C



Maximum Avalanche Energy  $E_{\text{AV}} = f \text{ (starting } T_{\text{ch}}) : V_{\text{DD}} = 60 \text{ V}, I_{\text{AV}} \leq 3.5 \text{ A}$ 



Transient Thermal Impedance  $Z_{t+(t)} = f(t) : D = 0$ 



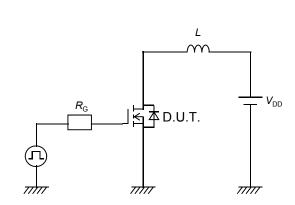


Figure 1. Unclamped inductive load test circuit

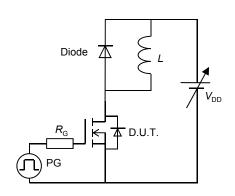


Figure 3. Switching test circuit

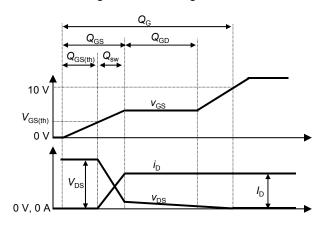


Figure 5. Gate charge waveform

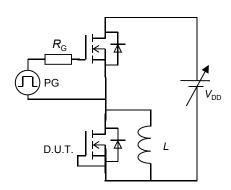


Figure 6. Diode reverse recovery test circuit

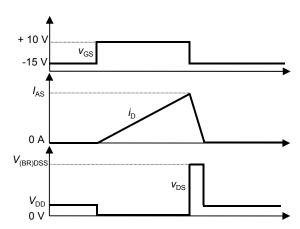


Figure 2. Unclamped inductive waveform

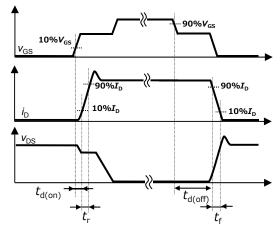


Figure 4. Switching times waveform

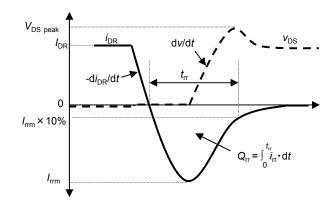
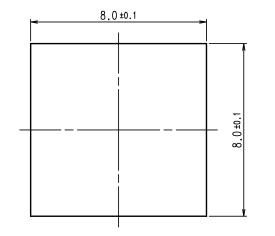
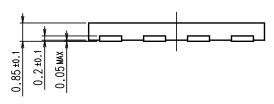


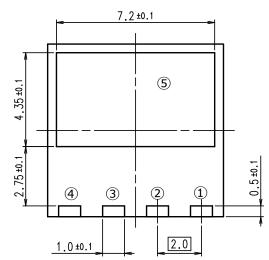
Figure 7. Diode reverse recovery waveform

### ■ Package Dimensions : DFN8x8 Package









#### **CONNECTION**

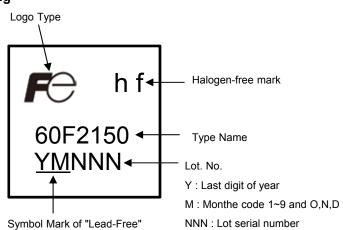
- 1) Gate
- 2 Sub-Source for Gate Drive
- 3,4 Source
- **5** DRAIN

**DIMENSIONS ARE IN MILLIMETERS** 

#### Notes

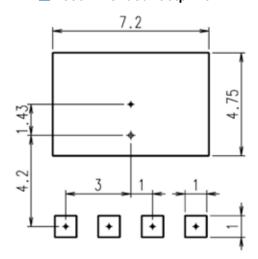
- 1.(): Reference dimensions.
- The metal part is covered with the solder plating, part of cutting is without the solder plating.

#### Marking



## $^{\star}$ The font (font type,size) and the trademark-size might be actually different.

### ■ Recommended footprint



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- Measurement equipment

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- Medical equipment

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